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Understanding <u>Embedded - FPGAs (Field Programmable Gate Array)</u>

Embedded - FPGAs, or Field Programmable Gate Arrays, are advanced integrated circuits that offer unparalleled flexibility and performance for digital systems. Unlike traditional fixed-function logic devices, FPGAs can be programmed and reprogrammed to execute a wide array of logical operations, enabling customized functionality tailored to specific applications. This reprogrammability allows developers to iterate designs quickly and implement complex functions without the need for custom hardware.

Applications of Embedded - FPGAs

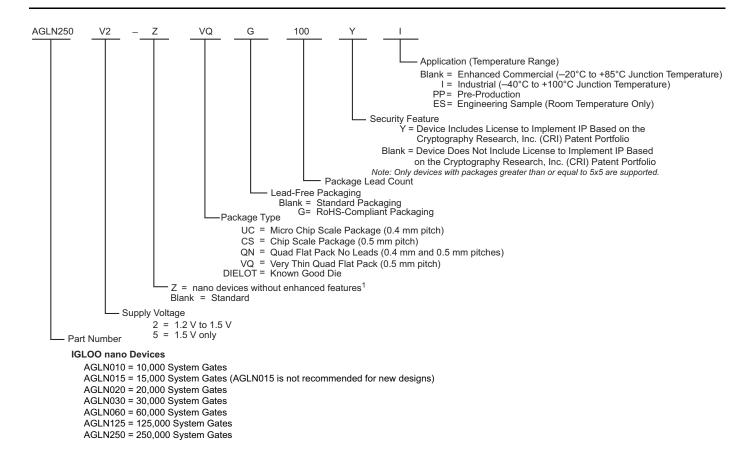
The versatility of Embedded - FPGAs makes them indispensable in numerous fields. In telecommunications.

Details	
Product Status	Active
Number of LABs/CLBs	-
Number of Logic Elements/Cells	3072
Total RAM Bits	36864
Number of I/O	60
Number of Gates	125000
Voltage - Supply	1.14V ~ 1.575V
Mounting Type	Surface Mount
Operating Temperature	-40°C ~ 100°C (TJ)
Package / Case	81-WFBGA, CSBGA
Supplier Device Package	81-CSP (5x5)
Purchase URL	https://www.e-xfl.com/product-detail/microchip-technology/agln125v2-csg81i

Email: info@E-XFL.COM

Address: Room A, 16/F, Full Win Commercial Centre, 573 Nathan Road, Mongkok, Hong Kong

IGLOO nano Ordering Information



Notes:

- Z-feature grade devices AGLN060Z, AGLN125Z, and AGLN250Z do not support the enhanced nano features of Schmitt Trigger input, bus hold (hold previous I/O state in Flash*Freeze mode), cold-sparing, hot-swap I/O capability and 1.2 V programming. The AGLN030 Z feature grade does not support Schmitt trigger input, bus hold and 1.2 V programming. For the VQ100, CS81, UC81, QN68, and QN48 packages, the Z feature grade and the N part number are not marked on the device. Z feature grade devices are not recommended for new designs.
- AGLN030 is available in the Z feature grade only.
- 3. Marking Information: IGLOO nano V2 devices do not have a V2 marking, but IGLOO nano V5 devices are marked with a V5 designator.

Devices Not Recommended For New Designs

AGLN015, AGLN030Z, AGLN060Z, AGLN125Z, and AGLN250Z are not recommended for new designs. For more information on obsoleted devices/packages, refer to the *PDN1503 - IGLOO nano Z and ProASIC3 nano Z Families*.

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6. Click **OK** to return to the FlashPoint – Programming File Generator window.

Note: I/O States During programming are saved to the ADB and resulting programming files after completing programming file generation.

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Combinatorial Cells Contribution—P_{C-CELL}

 $P_{C-CELL} = N_{C-CELL} * \alpha_1 / 2 * PAC7 * F_{CLK}$

N_{C-CFLL} is the number of VersaTiles used as combinatorial modules in the design.

 α_{1} is the toggle rate of VersaTile outputs—guidelines are provided in Table 2-19 on page 2-14.

F_{CLK} is the global clock signal frequency.

Routing Net Contribution—P_{NET}

 $P_{NET} = (N_{S-CELL} + N_{C-CELL}) * \alpha_1 / 2 * PAC8 * F_{CLK}$

N_{S-CELL} is the number of VersaTiles used as sequential modules in the design.

N_{C-CFLL} is the number of VersaTiles used as combinatorial modules in the design.

 α_1 is the toggle rate of VersaTile outputs—guidelines are provided in Table 2-19 on page 2-14.

F_{CLK} is the global clock signal frequency.

I/O Input Buffer Contribution—PINPUTS

 $P_{INPUTS} = N_{INPUTS} * \alpha_2 / 2 * PAC9 * F_{CLK}$

N_{INPLITS} is the number of I/O input buffers used in the design.

 α_2 is the I/O buffer toggle rate—guidelines are provided in Table 2-19 on page 2-14.

F_{CLK} is the global clock signal frequency.

I/O Output Buffer Contribution—POUTPUTS

 $P_{OUTPUTS} = N_{OUTPUTS} * \alpha_2 / 2 * \beta_1 * PAC10 * F_{CLK}$

 $N_{\mbox{OUTPUTS}}$ is the number of I/O output buffers used in the design.

 α_2 is the I/O buffer toggle rate—guidelines are provided in Table 2-19 on page 2-14.

 β_1 is the I/O buffer enable rate—guidelines are provided in Table 2-20 on page 2-14.

F_{CLK} is the global clock signal frequency.

RAM Contribution—P_{MEMORY}

 $\mathsf{P}_{\mathsf{MEMORY}} = \mathsf{PAC11} * \mathsf{N}_{\mathsf{BLOCKS}} * \mathsf{F}_{\mathsf{READ\text{-}CLOCK}} * \beta_2 + \mathsf{PAC12} * \mathsf{N}_{\mathsf{BLOCK}} * \mathsf{F}_{\mathsf{WRITE\text{-}CLOCK}} * \beta_3$

N_{BLOCKS} is the number of RAM blocks used in the design.

F_{READ-CLOCK} is the memory read clock frequency.

 β_2 is the RAM enable rate for read operations.

F_{WRITE-CLOCK} is the memory write clock frequency.

 β_3 is the RAM enable rate for write operations—guidelines are provided in Table 2-20 on page 2-14.

PLL Contribution—P_{PLL}

P_{PLL} = PDC4 + PAC13 *F_{CLKOUT}

F_{CLKOUT} is the output clock frequency.¹

If a PLL is used to generate more than one output clock, include each output clock in the formula by adding its corresponding contribution (PAC13* FCLKOUT product) to the total PLL contribution.



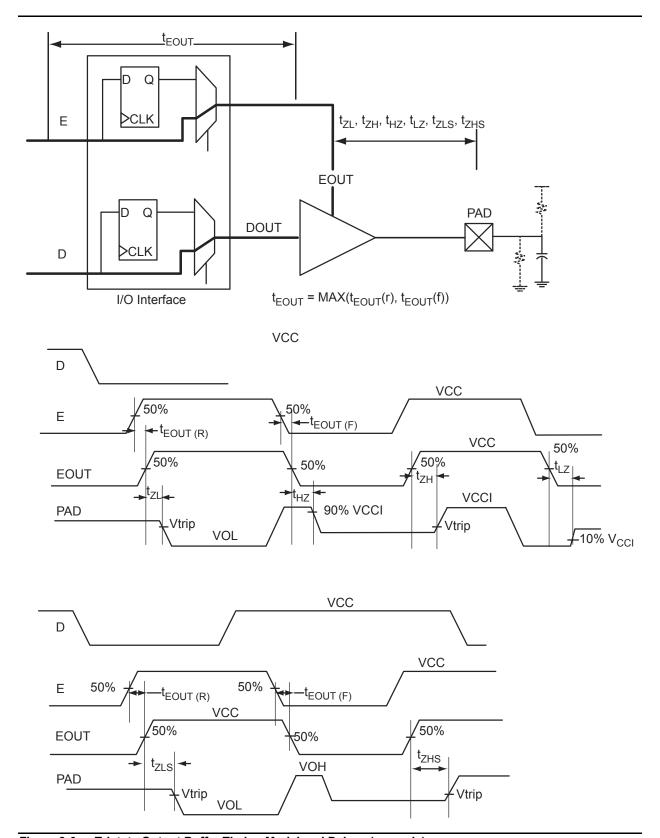


Figure 2-6 • Tristate Output Buffer Timing Model and Delays (example)

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IGLOO nano DC and Switching Characteristics

Applies to IGLOO nano at 1.2 V Core Operating Conditions

Table 2-26 • Summary of I/O Timing Characteristics—Software Default Settings
STD Speed Grade, Commercial-Case Conditions: T_J = 70°C, Worst-Case VCC = 1.14 V,
Worst-Case VCCI = 3.0 V

I/O Standard	Drive Strength (mA)	Equiv. Software Default Drive Strength Option ¹	Slew Rate	Capacitive Load (pF)	tвоит	t _{DP}	t _{DIN}	tpy)	t _{PYS}	^t Eo∪T	tzı	tzн	t _{LZ}	thz	Units
3.3 V LVTTL / 3.3 V LVCMOS	8 mA	8 mA	High	5 pF	1.55	2.31	0.26	0.97	1.36	1.10	2.34	1.90	2.43	3.14	ns
3.3 V LVCMOS Wide Range ²	100 μΑ	8 mA	High	5 pF	1.55	3.25	0.26	1.31	1.91	1.10	3.25	2.61	3.38	4.27	ns
2.5 V LVCMOS	8 mA	8 mA	High	5 pF	1.55	2.30	0.26	1.21	1.39	1.10	2.33	2.04	2.41	2.99	ns
1.8 V LVCMOS	4 mA	4 mA	High	5 pF	1.55	2.49	0.26	1.13	1.59	1.10	2.53	2.34	2.42	2.81	ns
1.5 V LVCMOS	2 mA	2 mA	High	5 pF	1.55	2.78	0.26	1.27	1.77	1.10	2.82	2.62	2.44	2.74	ns
1.2 V LVCMOS	1 mA	1 mA	High	5 pF	1.55	3.50	0.26	1.56	2.27	1.10	3.37	3.10	2.55	2.66	ns
1.2 V LVCMOS Wide Range ³	100 μΑ	1 mA	High	5 pF	1.55	3.50	0.26	1.56	2.27	1.10	3.37	3.10	2.55	2.66	ns

Notes:

- The minimum drive strength for any LVCMOS 1.2 V or LVCMOS 3.3 V software configuration when run in wide range is ±100 μA. Drive strength displayed in the software is supported for normal range only. For a detailed I/V curve, refer to the IBIS models.
- 2. All LVCMOS 3.3 V software macros support LVCMOS 3.3 V wide range, as specified in the JESD8-B specification.
- 3. All LVCMOS 1.2 V software macros support LVCMOS 1.2 V side range as specified in the JESD8-12 specification.
- 4. For specific junction temperature and voltage supply levels, refer to Table 2-6 on page 2-6 for derating values.

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IGLOO nano DC and Switching Characteristics

Single-Ended I/O Characteristics

3.3 V LVTTL / 3.3 V LVCMOS

Low-Voltage Transistor–Transistor Logic (LVTTL) is a general purpose standard (EIA/JESD) for 3.3 V applications. It uses an LVTTL input buffer and push-pull output buffer.

Table 2-34 • Minimum and Maximum DC Input and Output Levels

3.3 V LVTTL / 3.3 V LVCMOS	٧	TL.	v	IH	VOL	VOH	IOL	ЮН	IOSL	юзн	IIL 1	IIH ²
Drive Strength	Min. V	Max. V	Min. V	Max. V	Max. V	Min. V	mA	mA	Max. mA ³	Max. mA ³	μ Α ⁴	μ Α ⁴
2 mA	-0.3	0.8	2	3.6	0.4	2.4	2	2	25	27	10	10
4 mA	-0.3	8.0	2	3.6	0.4	2.4	4	4	25	27	10	10
6 mA	-0.3	8.0	2	3.6	0.4	2.4	6	6	51	54	10	10
8 mA	-0.3	0.8	2	3.6	0.4	2.4	8	8	51	54	10	10

Notes:

- 1. I_{IL} is the input leakage current per I/O pin over recommended operating conditions where –0.3 < VIN < VIL.
- 2. I_{IH} is the input leakage current per I/O pin over recommended operating conditions where VIH < VIN < VCCI. Input current is larger when operating outside recommended ranges.
- 3. Currents are measured at high temperature (100°C junction temperature) and maximum voltage.
- 4. Currents are measured at 85°C junction temperature.
- 5. Software default selection highlighted in gray.

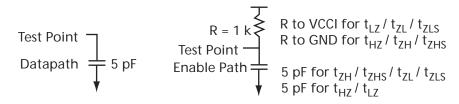


Figure 2-7 • AC Loading

Table 2-35 • 3.3 V LVTTL/LVCMOS AC Waveforms, Measuring Points, and Capacitive Loads

Input LOW (V)	Input HIGH (V)	Measuring Point* (V)	C _{LOAD} (pF)
0	3.3	1.4	5

Note: *Measuring point = Vtrip. See Table 2-23 on page 2-20 for a complete table of trip points.

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Applies to 1.2 V DC Core Voltage

Table 2-43 • 3.3 V LVCMOS Wide Range Low Slew – Applies to 1.2 V DC Core Voltage

Commercial-Case Conditions: T_J = 70°C, Worst-Case VCC = 1.14 V, Worst-Case VCCI = 2.7 V

Drive Strength	Equivalent Software Default Drive Strength Option ¹	Speed Grade	t _{DOUT}	t _{DP}	t _{DIN}	t _{PY}	t _{PYS}	t _{EOUT}	t _{ZL}	t _{ZH}	t _{LZ}	t _{HZ}	Units
100 μΑ	2 mA	STD	1.55	6.01	0.26	1.31	1.91	1.10	6.01	5.66	3.02	3.49	ns
100 μΑ	4 mA	STD	1.55	6.01	0.26	1.31	1.91	1.10	6.01	5.66	3.02	3.49	ns
100 μΑ	6 mA	STD	1.55	5.02	0.26	1.31	1.91	1.10	5.02	4.76	3.38	4.10	ns
100 μΑ	8 mA	STD	1.55	5.02	0.26	1.31	1.91	1.10	5.02	4.76	3.38	4.10	ns

Notes:

Table 2-44 • 3.3 V LVCMOS Wide Range High Slew – Applies to 1.2 V DC Core Voltage

Commercial-Case Conditions: T_{.I} = 70°C, Worst-Case VCC = 1.14 V, Worst-Case VCCI = 2.7 V

Drive Strength	Equivalent Software Default Drive Strength Option ¹	Speed Grade	t _{DOUT}	t _{DP}	t _{DIN}	t _{PY}	t _{PYS}	t _{EOUT}	t _{ZL}	t _{ZH}	t _{LZ}	t _{HZ}	Units
100 μΑ	2 mA	STD	1.55	3.82	0.26	1.31	1.91	1.10	3.82	3.15	3.01	3.65	ns
100 μΑ	4 mA	STD	1.55	3.82	0.26	1.31	1.91	1.10	3.82	3.15	3.01	3.65	ns
100 μΑ	6 mA	STD	1.55	3.25	0.26	1.31	1.91	1.10	3.25	2.61	3.38	4.27	ns
100 μΑ	8 mA	STD	1.55	3.25	0.26	1.31	1.91	1.10	3.25	2.61	3.38	4.27	ns

Notes:

- 2. For specific junction temperature and voltage supply levels, refer to Table 2-6 on page 2-6 for derating values.
- 3. Software default selection highlighted in gray.

The minimum drive strength for any LVCMOS 3.3 V software configuration when run in wide range is ±100 μA. Drive strength displayed in the software is supported for normal range only. For a detailed I/V curve, refer to the IBIS models.

^{2.} For specific junction temperature and voltage supply levels, refer to Table 2-6 on page 2-6 for derating values.

^{1.} The minimum drive strength for any LVCMOS 3.3 V software configuration when run in wide range is ±100 μA. Drive strength displayed in the software is supported for normal range only. For a detailed I/V curve, refer to the IBIS models.

1.5 V LVCMOS (JESD8-11)

Low-Voltage CMOS for 1.5 V is an extension of the LVCMOS standard (JESD8-5) used for general purpose 1.5 V applications. It uses a 1.5 V input buffer and a push-pull output buffer.

Table 2-57 • Minimum and Maximum DC Input and Output Levels

1.5 V LVCMOS		VIL	VIH		VOL	VOH	IOL	ЮН	IOSL	IOSH	IIL ¹	IIH ²
Drive Strength	Min. V	Max. V	Min. V	Max. V	Max. V	Min. V	mA	mA	Max. mA ³	Max. mA ³	μ Α ⁴	μ Α ⁴
2 mA	-0.3	0.35 * VCCI	0.65 * VCCI	3.6	0.25 * VCCI	0.75 * VCCI	2	2	13	16	10	10

Notes:

- 1. I_{II} is the input leakage current per I/O pin over recommended operating conditions where –0.3 < VIN < VIL.
- 2. IIH is the input leakage current per I/O pin over recommended operating conditions where VIH < VIN < VCCI. Input current is larger when operating outside recommended ranges.
- 3. Currents are measured at high temperature (100°C junction temperature) and maximum voltage.
- 4. Currents are measured at 85°C junction temperature.
- 5. Software default selection highlighted in gray.

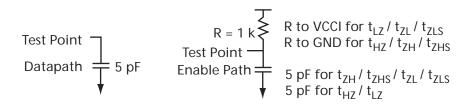


Figure 2-10 • AC Loading

Table 2-58 • 1.5 V LVCMOS AC Waveforms, Measuring Points, and Capacitive Loads

Input LOW (V)	Input HIGH (V)	Measuring Point* (V)	C _{LOAD} (pF)
0	1.5	0.75	5

Note: *Measuring point = Vtrip. See Table 2-23 on page 2-20 for a complete table of trip points.

DDR Module Specifications

Note: DDR is not supported for AGLN010, AGLN015, and AGLN020 devices.

Input DDR Module

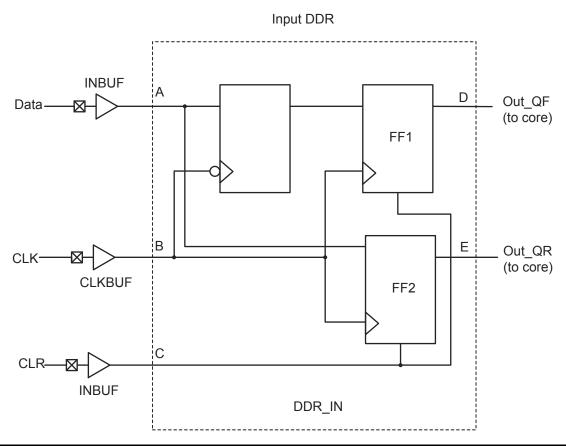


Figure 2-17 • Input DDR Timing Model

Table 2-78 • Parameter Definitions

Parameter Name	Parameter Definition	Measuring Nodes (from, to)
t _{DDRICLKQ1}	Clock-to-Out Out_QR	B, D
t _{DDRICLKQ2}	Clock-to-Out Out_QF	B, E
t _{DDRISUD}	Data Setup Time of DDR input	A, B
t _{DDRIHD}	Data Hold Time of DDR input	A, B
t _{DDRICLR2Q1}	Clear-to-Out Out_QR	C, D
t _{DDRICLR2Q2}	Clear-to-Out Out_QF	C, E
t _{DDRIREMCLR}	Clear Removal	C, B
t _{DDRIRECCLR}	Clear Recovery	C, B

VersaTile Characteristics

VersaTile Specifications as a Combinatorial Module

The IGLOO nano library offers all combinations of LUT-3 combinatorial functions. In this section, timing characteristics are presented for a sample of the library. For more details, refer to the *IGLOO*, *ProASIC3*, *SmartFusion and Fusion Macro Library Guide for Software v10.1*.

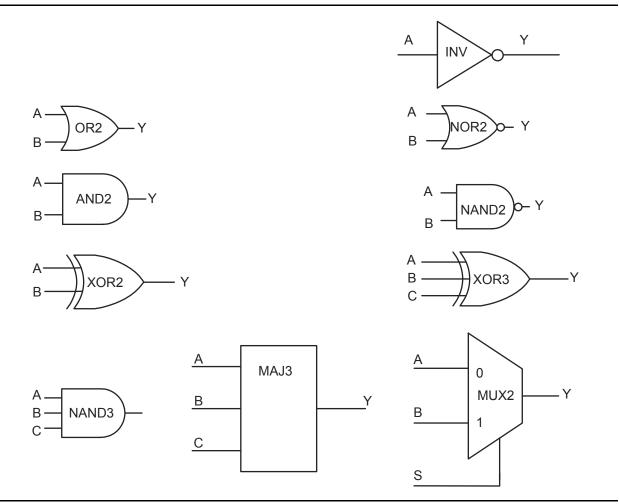


Figure 2-21 • Sample of Combinatorial Cells

Global Resource Characteristics

AGLN125 Clock Tree Topology

Clock delays are device-specific. Figure 2-25 is an example of a global tree used for clock routing. The global tree presented in Figure 2-25 is driven by a CCC located on the west side of the AGLN125 device. It is used to drive all D-flip-flops in the device.

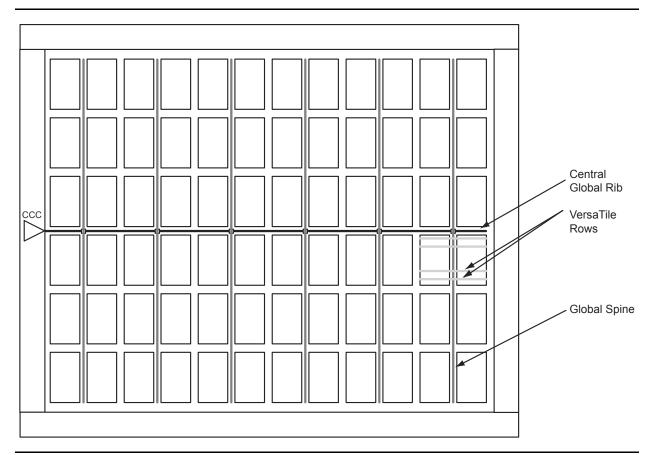


Figure 2-25 • Example of Global Tree Use in an AGLN125 Device for Clock Routing



Table 2-98 • AGLN125 Global Resource Commercial-Case Conditions: T_J = 70°C, VCC = 1.14 V

		S	itd.	
Parameter	Description	Min. ¹	Max. ²	Units
t _{RCKL}	Input Low Delay for Global Clock	2.08	2.54	ns
t _{RCKH}	Input High Delay for Global Clock	2.15	2.77	ns
t _{RCKMPWH}	Minimum Pulse Width HIGH for Global Clock	1.40		ns
t _{RCKMPWL}	Minimum Pulse Width LOW for Global Clock	1.65		ns
t _{RCKSW}	Maximum Skew for Global Clock		0.62	ns

Notes:

- 1. Value reflects minimum load. The delay is measured from the CCC output to the clock pin of a sequential element, located in a lightly loaded row (single element is connected to the global net).
- 2. Value reflects maximum load. The delay is measured on the clock pin of the farthest sequential element, located in a fully loaded row (all available flip-flops are connected to the global net in the row).
- 3. For specific junction temperature and voltage supply levels, refer to Table 2-7 on page 2-7 for derating values.

Table 2-99 • AGLN250 Global Resource
Commercial-Case Conditions: T_J = 70°C, VCC = 1.14 V

		S	td.	
Parameter	Description	Min. ¹	Max. ²	Units
t _{RCKL}	Input Low Delay for Global Clock	2.11	2.57	ns
t _{RCKH}	Input High Delay for Global Clock	2.19	2.81	ns
t _{RCKMPWH}	Minimum Pulse Width High for Global Clock	1.40		ns
t _{RCKMPWL}	Minimum Pulse Width Low for Global Clock	1.65		ns
t _{RCKSW}	Maximum Skew for Global Clock		0.62	ns

Notes:

- 1. Value reflects minimum load. The delay is measured from the CCC output to the clock pin of a sequential element, located in a lightly loaded row (single element is connected to the global net).
- 2. Value reflects maximum load. The delay is measured on the clock pin of the farthest sequential element, located in a fully loaded row (all available flip-flops are connected to the global net in the row).
- 3. For specific junction temperature and voltage supply levels, refer to Table 2-7 on page 2-7 for derating values.



IGLOO nano DC and Switching Characteristics

Clock Conditioning Circuits

CCC Electrical Specifications

Timing Characteristics

Table 2-100 • IGLOO nano CCC/PLL Specification For IGLOO nano V2 OR V5 Devices, 1.5 V DC Core Supply Voltage

Parameter		Min.	Тур.	Max.	Units
Clock Conditioning Circuitry Input Frequency f _{IN_CCC}		1.5		250	MHz
Clock Conditioning Circuitry Output Frequency fout_co	CC	0.75		250	MHz
Delay Increments in Programmable Delay Blocks ^{1, 2}	·				ps
Number of Programmable Values in Each Programmal	ole Delay Block			32	
Serial Clock (SCLK) for Dynamic PLL ^{4,9}				100	MHz
Input Cycle-to-Cycle Jitter (peak magnitude)	ut Cycle-to-Cycle Jitter (peak magnitude)				ns
Acquisition Time					
	LockControl = 0			300	μs
	LockControl = 1			6.0	ms
Tracking Jitter ⁵					
	LockControl = 0			2.5	ns
	LockControl = 1			1.5	ns
Output Duty Cycle	•	48.5		51.5	%
Delay Range in Block: Programmable Delay 1 ^{1, 2}		1.25		15.65	ns
Delay Range in Block: Programmable Delay 2 ^{1, 2,}		0.025		15.65	ns
Delay Range in Block: Fixed Delay ^{1, 2}			3.5		ns
VCO Output Peak-to-Peak Period Jitter F _{CCC_OUT} ⁶	k Jitter Da	ta ^{6,7,8}			
	SSO ≤ 2	SSO ≤ 4	SSO ≤ 8	SSO ≤ 16	
0.75 MHz to 50 MHz	0.50	0.60	0.80	1.20	%
50 MHz to 250 MHz	2.50	4.00	6.00	12.00	%

Notes:

- 1. This delay is a function of voltage and temperature. See Table 2-6 on page 2-6 and Table 2-7 on page 2-7 for deratings.
- 2. $T_{.1} = 25$ °C, VCC = 1.5 V
- 3. When the CCC/PLL core is generated by Microsemi core generator software, not all delay values of the specified delay increments are available. Refer to the Libero SoC Online Help associated with the core for more information.
- 4. Maximum value obtained for a STD speed grade device in Worst-Case Commercial conditions. For specific junction temperature and voltage supply levels, refer to Table 2-6 on page 2-6 and Table 2-7 on page 2-7 for derating values.
- 5. Tracking jitter is defined as the variation in clock edge position of PLL outputs with reference to PLL input clock edge. Tracking jitter does not measure the variation in PLL output period, which is covered by the period jitter parameter.
- 6. VCO output jitter is calculated as a percentage of the VCO frequency. The jitter (in ps) can be calculated by multiplying the VCO period by the % jitter. The VCO jitter (in ps) applies to CCC_OUT, regardless of the output divider settings. For example, if the jitter on VCO is 300 ps, the jitter on CCC_OUT is also 300 ps, no matter what the settings are for the output divider.
- 7. Measurements done with LVTTL 3.3 V 8 mA I/O drive strength and high slew rate. VCC/VCCPLL = 1.425 V, VCCI = 3.3 V, VQ/PQ/TQ type of packages, 20 pF load.
- 8. SSOs are outputs that are synchronous to a single clock domain and have their clock-to-out times within ±200 ps of each other. Switching I/Os are placed outside of the PLL bank. Refer to the "Simultaneously Switching Outputs (SSOs) and Printed Circuit Board Layout" section in the IGLOO nano FPGA Fabric User's Guide.
- 9. The AGLN010, AGLN015, and AGLN020 devices do not support PLLs.

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1.2 V DC Core Voltage

Table 2-104 • RAM4K9

Commercial-Case Conditions: $T_J = 70$ °C, Worst-Case VCC = 1.14 V

Parameter	Description	Std.	Units
t _{AS}	Address setup time	1.28	ns
t _{AH}	Address hold time	0.25	ns
t _{ENS}	REN, WEN setup time	1.25	ns
t _{ENH}	REN, WEN hold time	0.25	ns
t _{BKS}	BLK setup time	2.54	ns
t _{BKH}	BLK hold time	0.25	ns
t _{DS}	Input data (DIN) setup time	1.10	ns
t _{DH}	Input data (DIN) hold time	0.55	ns
t _{CKQ1}	Clock HIGH to new data valid on DOUT (output retained, WMODE = 0)	5.51	ns
	Clock HIGH to new data valid on DOUT (flow-through, WMODE = 1)	4.77	ns
t _{CKQ2}	Clock HIGH to new data valid on DOUT (pipelined)	2.82	ns
t _{C2CWWL} 1	Address collision clk-to-clk delay for reliable write after write on same address; applicable to closing edge	0.30	ns
t _{C2CRWH} 1	Address collision clk-to-clk delay for reliable read access after write on same address; applicable to opening edge	0.89	ns
t _{C2CWRH} 1	Address collision clk-to-clk delay for reliable write access after read on same address; applicable to opening edge	1.01	ns
t _{RSTBQ}	RESET LOW to data out LOW on DOUT (flow-through)	3.21	ns
	RESET LOW to data out LOW on DO (pipelined)	3.21	ns
t _{REMRSTB}	RESET removal	0.93	ns
t _{RECRSTB}	RESET recovery	4.94	ns
t _{MPWRSTB}	RESET minimum pulse width	1.18	ns
t _{CYC}	Clock cycle time	10.90	ns
F _{MAX}	Maximum frequency	92	MHz

Notes:

^{1.} For more information, refer to the application note AC374: Simultaneous Read-Write Operations in Dual-Port SRAM for Flash-Based FPGAs and SoC FPGAs App Note.

^{2.} For specific junction temperature and voltage supply levels, refer to Table 2-7 on page 2-7 for derating values.



3 - Pin Descriptions

Supply Pins

GND Ground

Ground supply voltage to the core, I/O outputs, and I/O logic.

GNDQ Ground (quiet)

Quiet ground supply voltage to input buffers of I/O banks. Within the package, the GNDQ plane is decoupled from the simultaneous switching noise originated from the output buffer ground domain. This minimizes the noise transfer within the package and improves input signal integrity. GNDQ must always be connected to GND on the board.

VCC Core Supply Voltage

Supply voltage to the FPGA core, nominally 1.5 V for IGLOO nano V5 devices, and 1.2 V or 1.5 V for IGLOO nano V2 devices. VCC is required for powering the JTAG state machine in addition to VJTAG. Even when a device is in bypass mode in a JTAG chain of interconnected devices, both VCC and VJTAG must remain powered to allow JTAG signals to pass through the device.

VCCIBx I/O Supply Voltage

Supply voltage to the bank's I/O output buffers and I/O logic. Bx is the I/O bank number. There are up to eight I/O banks on low power flash devices plus a dedicated VJTAG bank. Each bank can have a separate VCCI connection. All I/Os in a bank will run off the same VCCIBx supply. VCCI can be 1.2 V, 1.5 V, 1.8 V, 2.5 V, or 3.3 V, nominal voltage. Unused I/O banks should have their corresponding VCCI pins tied to GND.

VMVx I/O Supply Voltage (quiet)

Quiet supply voltage to the input buffers of each I/O bank. *x* is the bank number. Within the package, the VMV plane biases the input stage of the I/Os in the I/O banks. This minimizes the noise transfer within the package and improves input signal integrity. Each bank must have at least one VMV connection, and no VMV should be left unconnected. All I/Os in a bank run off the same VMVx supply. VMV is used to provide a quiet supply voltage to the input buffers of each I/O bank. VMVx can be 1.2 V, 1.5 V, 1.8 V, 2.5 V, or 3.3 V, nominal voltage. Unused I/O banks should have their corresponding VMV pins tied to GND. VMV and VCCI should be at the same voltage within a given I/O bank. Used VMV pins must be connected to the corresponding VCCI pins of the same bank (i.e., VMV0 to VCCIB0, VMV1 to VCCIB1, etc.).

VCCPLA/B/C/D/E/F PLL Supply Voltage

Supply voltage to analog PLL, nominally 1.5 V or 1.2 V.

When the PLLs are not used, the Microsemi Designer place-and-route tool automatically disables the unused PLLs to lower power consumption. The user should tie unused VCCPLx and VCOMPLx pins to ground. Microsemi recommends tying VCCPLx to VCC and using proper filtering circuits to decouple VCC noise from the PLLs. Refer to the PLL Power Supply Decoupling section of the "Clock Conditioning Circuits in IGLOO and ProASIC3 Devices" chapter in the *IGLOO nano FPGA Fabric User's Guide* for a complete board solution for the PLL analog power supply and ground.

There is one VCCPLF pin on IGLOO nano devices.

VCOMPLA/B/C/D/E/F PLL Ground

Ground to analog PLL power supplies. When the PLLs are not used, the Microsemi Designer place-and-route tool automatically disables the unused PLLs to lower power consumption. The user should tie unused VCCPLx and VCOMPLx pins to ground.

There is one VCOMPLF pin on IGLOO nano devices.

VJTAG JTAG Supply Voltage

Low power flash devices have a separate bank for the dedicated JTAG pins. The JTAG pins can be run at any voltage from 1.5 V to 3.3 V (nominal). Isolating the JTAG power supply in a separate I/O bank gives greater flexibility in supply selection and simplifies power supply and PCB design. If the JTAG



Package Pin Assignments

UC36		
Pin Number	AGLN010 Function	
A1	IO21RSB1	
A2	IO18RSB1	
A3	IO13RSB1	
A4	GDC0/IO00RSB0	
A5	IO06RSB0	
A6	GDA0/IO04RSB0	
B1	GEC0/IO37RSB1	
B2	IO20RSB1	
В3	IO15RSB1	
B4	IO09RSB0	
B5	IO08RSB0	
B6	IO07RSB0	
C1	IO22RSB1	
C2	GEA0/IO34RSB1	
C3	GND	
C4	GND	
C5	VCCIB0	
C6	IO02RSB0	
D1	IO33RSB1	
D2	VCCIB1	
D3	VCC	
D4	VCC	
D5	IO10RSB0	
D6	IO11RSB0	
E1	IO32RSB1	
E2	FF/IO31RSB1	
E3	TCK	
E4	VPUMP	
E5	TRST	
E6	VJTAG	
F1	IO29RSB1	
F2	IO25RSB1	
F3	IO23RSB1	
F4	TDI	

UC36		
Pin Number	AGLN010 Function	
F5	TMS	
F6	TDO	

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VQ100		
Pin Number	AGLN030Z Function	
1	GND	
2	IO82RSB1	
3	IO81RSB1	
4	IO80RSB1	
5	IO79RSB1	
6	IO78RSB1	
7	IO77RSB1	
8	IO76RSB1	
9	GND	
10	IO75RSB1	
11	IO74RSB1	
12	GEC0/IO73RSB1	
13	GEA0/IO72RSB1	
14	GEB0/IO71RSB1	
15	IO70RSB1	
16	IO69RSB1	
17	VCC	
18	VCCIB1	
19	IO68RSB1	
20	IO67RSB1	
21	IO66RSB1	
22	IO65RSB1	
23	IO64RSB1	
24	IO63RSB1	
25	IO62RSB1	
26	IO61RSB1	
27	FF/IO60RSB1	
28	IO59RSB1	
29	IO58RSB1	
30	IO57RSB1	
31	IO56RSB1	
32	IO55RSB1	
33	IO54RSB1	
34	IO53RSB1	
35	IO52RSB1	

VQ100		
Pin Number	AGLN030Z Function	
36	IO51RSB1	
37	VCC	
38	GND	
39	VCCIB1	
40	IO49RSB1	
41	IO47RSB1	
42	IO46RSB1	
43	IO45RSB1	
44	IO44RSB1	
45	IO43RSB1	
46	IO42RSB1	
47	TCK	
48	TDI	
49	TMS	
50	NC	
51	GND	
52	VPUMP	
53	NC	
54	TDO	
55	TRST	
56	VJTAG	
57	IO41RSB0	
58	IO40RSB0	
59	IO39RSB0	
60	IO38RSB0	
61	IO37RSB0	
62	IO36RSB0	
63	GDB0/IO34RSB0	
64	GDA0/IO33RSB0	
65	GDC0/IO32RSB0	
66	VCCIB0	
67	GND	
68	VCC	
69	IO31RSB0	
70	IO30RSB0	

VQ100		
Pin Number	AGLN030Z Function	
71	IO29RSB0	
72	IO28RSB0	
73	IO27RSB0	
74	IO26RSB0	
75	IO25RSB0	
76	IO24RSB0	
77	IO23RSB0	
78	IO22RSB0	
79	IO21RSB0	
80	IO20RSB0	
81	IO19RSB0	
82	IO18RSB0	
83	IO17RSB0	
84	IO16RSB0	
85	IO15RSB0	
86	IO14RSB0	
87	VCCIB0	
88	GND	
89	VCC	
90	IO12RSB0	
91	IO10RSB0	
92	IO08RSB0	
93	IO07RSB0	
94	IO06RSB0	
95	IO05RSB0	
96	IO04RSB0	
97	IO03RSB0	
98	IO02RSB0	
99	IO01RSB0	
100	IO00RSB0	



Package Pin Assignments

VQ100			VQ100
Pin Number	AGLN060 Function	Pin Number	AGLN060 Function
1	GND	36	IO61RSB1
2	GAA2/IO51RSB1	37	VCC
3	IO52RSB1	38	GND
4	GAB2/IO53RSB1	39	VCCIB1
5	IO95RSB1	40	IO60RSB1
6	GAC2/IO94RSB1	41	IO59RSB1
7	IO93RSB1	42	IO58RSB1
8	IO92RSB1	43	IO57RSB1
9	GND	44	GDC2/IO56RSB1
10	GFB1/IO87RSB1	45*	GDB2/IO55RSB1
11	GFB0/IO86RSB1	46	GDA2/IO54RSB1
12	VCOMPLF	47	TCK
13	GFA0/IO85RSB1	48	TDI
14	VCCPLF	49	TMS
15	GFA1/IO84RSB1	50	VMV1
16	GFA2/IO83RSB1	51	GND
17	VCC	52	VPUMP
18	VCCIB1	53	NC
19	GEC1/IO77RSB1	54	TDO
20	GEB1/IO75RSB1	55	TRST
21	GEB0/IO74RSB1	56	VJTAG
22	GEA1/IO73RSB1	57	GDA1/IO49RSB0
23	GEA0/IO72RSB1	58	GDC0/IO46RSB0
24	VMV1	59	GDC1/IO45RSB0
25	GNDQ	60	GCC2/IO43RSB0
26	GEA2/IO71RSB1	61	GCB2/IO42RSB0
27	FF/GEB2/IO70RSB1	62	GCA0/IO40RSB0
28	GEC2/IO69RSB1	63	GCA1/IO39RSB0
29	IO68RSB1	64	GCC0/IO36RSB0
30	IO67RSB1	65	GCC1/IO35RSB0
31	IO66RSB1	66	VCCIB0
32	IO65RSB1	67	GND
33	IO64RSB1	68	VCC
34	IO63RSB1	69	IO31RSB0
35	IO62RSB1	70	GBC2/IO29RSB0

VQ100		
Pin Number	AGLN060 Function	
71	GBB2/IO27RSB0	
72	IO26RSB0	
73	GBA2/IO25RSB0	
74	VMV0	
75	GNDQ	
76	GBA1/IO24RSB0	
77	GBA0/IO23RSB0	
78	GBB1/IO22RSB0	
79	GBB0/IO21RSB0	
80	GBC1/IO20RSB0	
81	GBC0/IO19RSB0	
82	IO18RSB0	
83	IO17RSB0	
84	IO15RSB0	
85	IO13RSB0	
86	IO11RSB0	
87	VCCIB0	
88	GND	
89	VCC	
90	IO10RSB0	
91	IO09RSB0	
92	IO08RSB0	
93	GAC1/IO07RSB0	
94	GAC0/IO06RSB0	
95	GAB1/IO05RSB0	
96	GAB0/IO04RSB0	
97	GAA1/IO03RSB0	
98	GAA0/IO02RSB0	
99	IO01RSB0	
100	IO00RSB0	

Note: *The bus hold attribute (hold previous I/O state in Flash*Freeze mode) is not supported for pin 45 in AGLN060-VQ100.

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VQ100		
AGLN060Z Function		
GND		
GAA2/IO51RSB1		
IO52RSB1		
GAB2/IO53RSB1		
IO95RSB1		
GAC2/IO94RSB1		
IO93RSB1		
IO92RSB1		
GND		
GFB1/IO87RSB1		
GFB0/IO86RSB1		
VCOMPLF		
GFA0/IO85RSB1		
VCCPLF		
GFA1/IO84RSB1		
GFA2/IO83RSB1		
VCC		
VCCIB1		
GEC1/IO77RSB1		
GEB1/IO75RSB1		
GEB0/IO74RSB1		
GEA1/IO73RSB1		
GEA0/IO72RSB1		
VMV1		
GNDQ		
GEA2/IO71RSB1		
FF/GEB2/IO70RSB1		
GEC2/IO69RSB1		
IO68RSB1		
IO67RSB1		
IO66RSB1		
IO65RSB1		
IO65RSB1		

	VQ100
Pin Number	AGLN060Z Function
35	IO62RSB1
36	IO61RSB1
37	VCC
38	GND
39	VCCIB1
40	IO60RSB1
41	IO59RSB1
42	IO58RSB1
43	IO57RSB1
44	GDC2/IO56RSB1
45*	GDB2/IO55RSB1
46	GDA2/IO54RSB1
47	TCK
48	TDI
49	TMS
50	VMV1
51	GND
52	VPUMP
53	NC
54	TDO
55	TRST
56	VJTAG
57	GDA1/IO49RSB0
58	GDC0/IO46RSB0
59	GDC1/IO45RSB0
60	GCC2/IO43RSB0
61	GCB2/IO42RSB0
62	GCA0/IO40RSB0
63	GCA1/IO39RSB0
64	GCC0/IO36RSB0
65	GCC1/IO35RSB0
66	VCCIB0
67	GND
68	VCC

VQ100		
Pin Number	AGLN060Z Function	
69	IO31RSB0	
70	GBC2/IO29RSB0	
71	GBB2/IO27RSB0	
72	IO26RSB0	
73	GBA2/IO25RSB0	
74	VMV0	
75	GNDQ	
76	GBA1/IO24RSB0	
77	GBA0/IO23RSB0	
78	GBB1/IO22RSB0	
79	GBB0/IO21RSB0	
80	GBC1/IO20RSB0	
81	GBC0/IO19RSB0	
82	IO18RSB0	
83	IO17RSB0	
84	IO15RSB0	
85	IO13RSB0	
86	IO11RSB0	
87	VCCIB0	
88	GND	
89	VCC	
90	IO10RSB0	
91	IO09RSB0	
92	IO08RSB0	
93	GAC1/IO07RSB0	
94	GAC0/IO06RSB0	
95	GAB1/IO05RSB0	
96	GAB0/IO04RSB0	
97	GAA1/IO03RSB0	
98	GAA0/IO02RSB0	
99	IO01RSB0	
100	IO00RSB0	

Note: *The bus hold attribute (hold previous I/O state in Flash*Freeze mode) is not supported for pin 45 in AGLN060Z-VQ100.



VQ100		
Pin		
Number	AGLN125Z Function	
1	GND	
2	GAA2/IO67RSB1	
3	IO68RSB1	
4	GAB2/IO69RSB1	
5	IO132RSB1	
6	GAC2/IO131RSB1	
7	IO130RSB1	
8	IO129RSB1	
9	GND	
10	GFB1/IO124RSB1	
11	GFB0/IO123RSB1	
12	VCOMPLF	
13	GFA0/IO122RSB1	
14	VCCPLF	
15	GFA1/IO121RSB1	
16	GFA2/IO120RSB1	
17	VCC	
18	VCCIB1	
19	GEC0/IO111RSB1	
20	GEB1/IO110RSB1	
21	GEB0/IO109RSB1	
22	GEA1/IO108RSB1	
23	GEA0/IO107RSB1	
24	VMV1	
25	GNDQ	
26	GEA2/IO106RSB1	
27	FF/GEB2/IO105RSB1	
28	GEC2/IO104RSB1	
29	IO102RSB1	
30	IO100RSB1	
31	IO99RSB1	
32	IO97RSB1	
33	IO96RSB1	
34	IO95RSB1	
35	IO94RSB1	
•	•	

VQ100		
Pin Number	AGLN125Z Function	
36	IO93RSB1	
37	VCC	
38	GND	
39	VCCIB1	
40	IO87RSB1	
41	IO84RSB1	
42	IO81RSB1	
43	IO75RSB1	
44	GDC2/IO72RSB1	
45	GDB2/IO71RSB1	
46	GDA2/IO70RSB1	
47	TCK	
48	TDI	
49	TMS	
50	VMV1	
51	GND	
52	VPUMP	
53	NC	
54	TDO	
55	TRST	
56	VJTAG	
57	GDA1/IO65RSB0	
58	GDC0/IO62RSB0	
59	GDC1/IO61RSB0	
60	GCC2/IO59RSB0	
61	GCB2/IO58RSB0	
62	GCA0/IO56RSB0	
63	GCA1/IO55RSB0	
64	GCC0/IO52RSB0	
65	GCC1/IO51RSB0	
66	VCCIB0	
67	GND	
68	VCC	
69	IO47RSB0	
70	GBC2/IO45RSB0	

VQ100	
Pin Number	AGLN125Z Function
71	GBB2/IO43RSB0
72	IO42RSB0
73	GBA2/IO41RSB0
74	VMV0
75	GNDQ
76	GBA1/IO40RSB0
77	GBA0/IO39RSB0
78	GBB1/IO38RSB0
79	GBB0/IO37RSB0
80	GBC1/IO36RSB0
81	GBC0/IO35RSB0
82	IO32RSB0
83	IO28RSB0
84	IO25RSB0
85	IO22RSB0
86	IO19RSB0
87	VCCIB0
88	GND
89	VCC
90	IO15RSB0
91	IO13RSB0
92	IO11RSB0
93	IO09RSB0
94	IO07RSB0
95	GAC1/IO05RSB0
96	GAC0/IO04RSB0
97	GAB1/IO03RSB0
98	GAB0/IO02RSB0
99	GAA1/IO01RSB0
100	GAA0/IO00RSB0